





60V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D T _A = +25°C		
001/	69mΩ @ V _{GS} = 10V	4.3A		
60V	100mΩ @ V _{GS} = 4.5V	3.5A		

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Motor control
- Transformer driving switch
- DC-DC Converters
- Power management functions
- Uninterrupted power supply

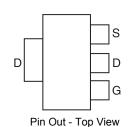
Features

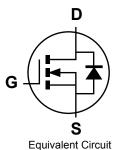
- 100% Unclamped Inductive Switch (UIS) test in production
- Fast switching speed
- Low on-resistance
- Lead-Free Finish; RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT223
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See diagram below
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.112 grams (approximate)







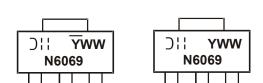
Ordering Information (Note 4)

Part Number	Qualification	Case	Packaging
DMN6069SE-13	Standard	SOT223	2,500 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Oll = Manufacturer's Marking N6069 = Marking Code

YWW = Date Code Marking for SAT (Shanghai Assembly/ Test site)

YWW = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Y or Y= Year (ex: 3 = 2013) WW = Week (01 - 53)



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Drain-Source Voltage	V_{DSS}	60	V	
Gate-Source Voltage	V_{GSS}	±20	V	
Continuous Drain Current (Note 6) V = 40V	T _A = +25°C T _A = +70°C	l _D	4.3 3.3	А
Continuous Drain Current (Note 6) V _{GS} = 10V	$T_C = +25$ °C $T_C = +70$ °C	I _D	10 8	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	25	Α	
Maximum Body Diode Continuous Current	Is	3.2	Α	

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Total Power Dissipation (Note 5)	T _A = +25°C	P _D	2.2	W	
Total Fower Dissipation (Note 3)	Ta = +70°C	FD	1.4	VV	
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	58	°C/W		
Total Power Dissipation (Note 5)		P_{D}	11	W	
Thermal Resistance, Junction to Case (Note 5)	$R_{ heta JC}$	8.9	°C/W		
Operating and Storage Temperature Range	$T_{J_i} T_{STG}$	-55 to +150	°C		

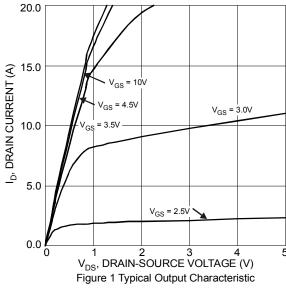
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

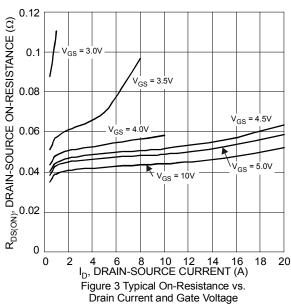
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	Symbol	IVIIII	ıуp	IVIAA	Onit	rest condition
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	V _{DS} = 60V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	1	_	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Desir Course On Besistance		_	47	69	mΩ	V _{GS} = 10V, I _D = 3A
Static Drain-Source On-Resistance	R _{DS} (ON)	_	54	100		V _{GS} = 4.5V, I _D = 2.4A
Diode Forward Voltage	V _{SD}	_	0.8	1.1	V	V _{GS} = 0V, I _S = 2.5A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	_	825	_		V _{DS} = 30V, V _{GS} = 0V f = 1MHz
Output Capacitance	Coss	_	40	_	pF	
Reverse Transfer Capacitance	C _{rss}	_	29	_		
Gate Resistance	R _G	_	2.3	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	7.2	_		V _{DS} = 30V, I _D = 12A
Total Gate Charge (V _{GS} = 10V)	Qg	_	16	_	nC	
Gate-Source Charge	Qgs	_	3.2	_	IIC	
Gate-Drain Charge	Q _{qd}	_	2.8	_		
Turn-On Delay Time	t _{D(on)}	_	3.8	_		V _{DD} = 30V, V _{GS} = 10V,
Turn-On Rise Time	tr	_	6.7	_	nS	
Turn-Off Delay Time	t _{D(off)}	_	16	_	115	$R_G = 6\Omega, I_D = 12A$
Turn-Off Fall Time	t _f	_	5.3	_		

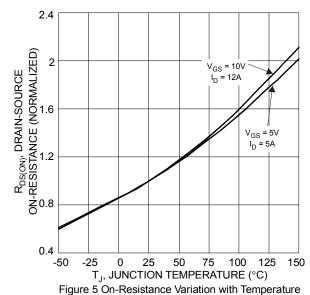
- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate
 Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.

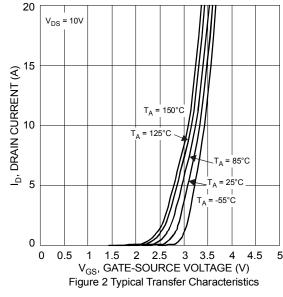


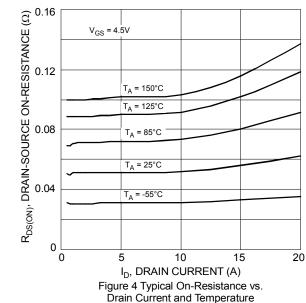








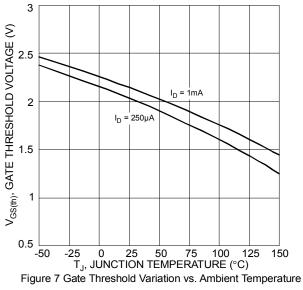


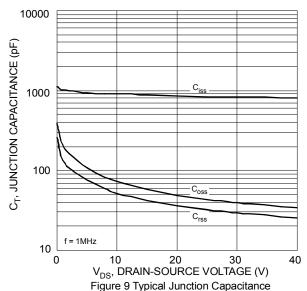


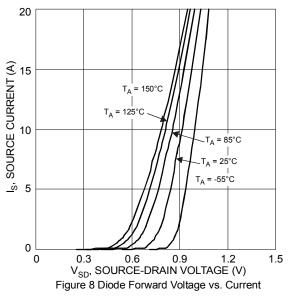
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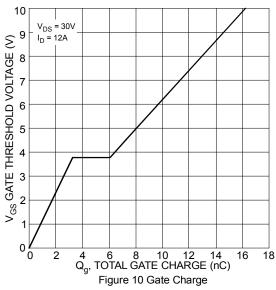
Figure 6 On-Resistance Variation with Temperature

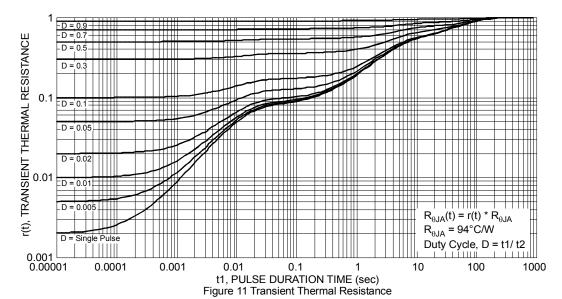








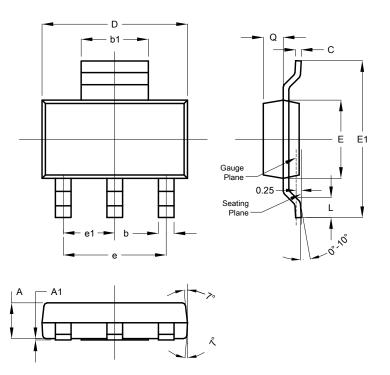






Package Outline Dimensions

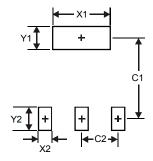
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SOT223					
Dim	Min	Max	Тур		
Α	1.55	1.65	1.60		
A1	0.010	0.15	0.05		
b	0.60	0.80	0.70		
b1	2.90	3.10	3.00		
С	0.20	0.30	0.25		
D	6.45	6.55	6.50		
E	3.45	3.55	3.50		
E1	6.90	7.10	7.00		
е	-	1	4.60		
e1	-	-	2.30		
L	0.85	1.05	0.95		
Q	0.84	0.94	0.89		
All Dimensions in mm					

Suggested Pad Layout

 $Please see AP02001 \ at \ http://www.diodes.com/datasheets/ap02001.pdf \ for \ the \ latest \ version.$



Dimensions	Value (in mm)		
X1	3.3		
X2	1.2		
Y1	1.6		
Y2	1.6		
C1	6.4		
C2	2.3		



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